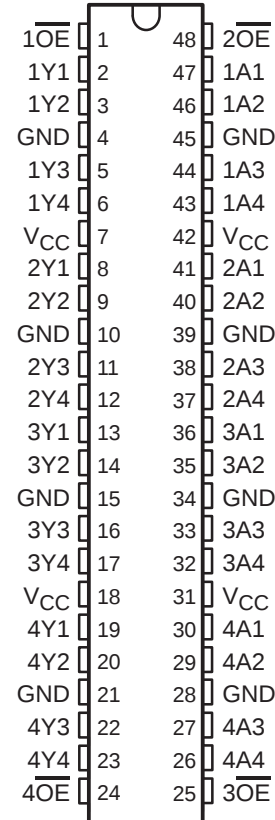


SN54LVTH16240, SN74LVTH16240 3.3-V ABT 16-BIT BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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- Members of the Texas Instruments *Widebus™* Family
- State-of-the-Art Advanced BiCMOS Technology (ABT) Design for 3.3-V Operation and Low Static-Power Dissipation
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V_{CC})
- Support Unregulated Battery Operation Down to 2.7 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at $V_{CC} = 3.3$ V, $T_A = 25^\circ\text{C}$
- I_{off} and Power-Up 3-State Support Hot Insertion
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- Latch-Up Performance Exceeds 500 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ($C = 200$ pF, $R = 0$)
- Package Options Include Plastic Shrink Small-Outline (DL) and Thin Shrink Small-Outline (DGG) Packages and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

SN54LVTH16240 . . . WD PACKAGE
SN74LVTH16240 . . . DGG OR DL PACKAGE
(TOP VIEW)



description

These 16-bit buffers/drivers are designed specifically for low-voltage (3.3-V) V_{CC} operation, but with the capability to provide a TTL interface to a 5-V system environment.

The 'LVTH16240 devices are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The devices can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. The devices provide inverting outputs and symmetrical active-low output-enable ($\overline{OE}$) inputs.

When V_{CC} is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, $\overline{OE}$ should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.



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**TEXAS
INSTRUMENTS**

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The SN54LVTH16240 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74LVTH16240 is characterized for operation from -40°C to 85°C .

INPUTS		OUTPUT Y
$\overline{OE}$	A	
L	H	L
L	L	H
H	X	Z

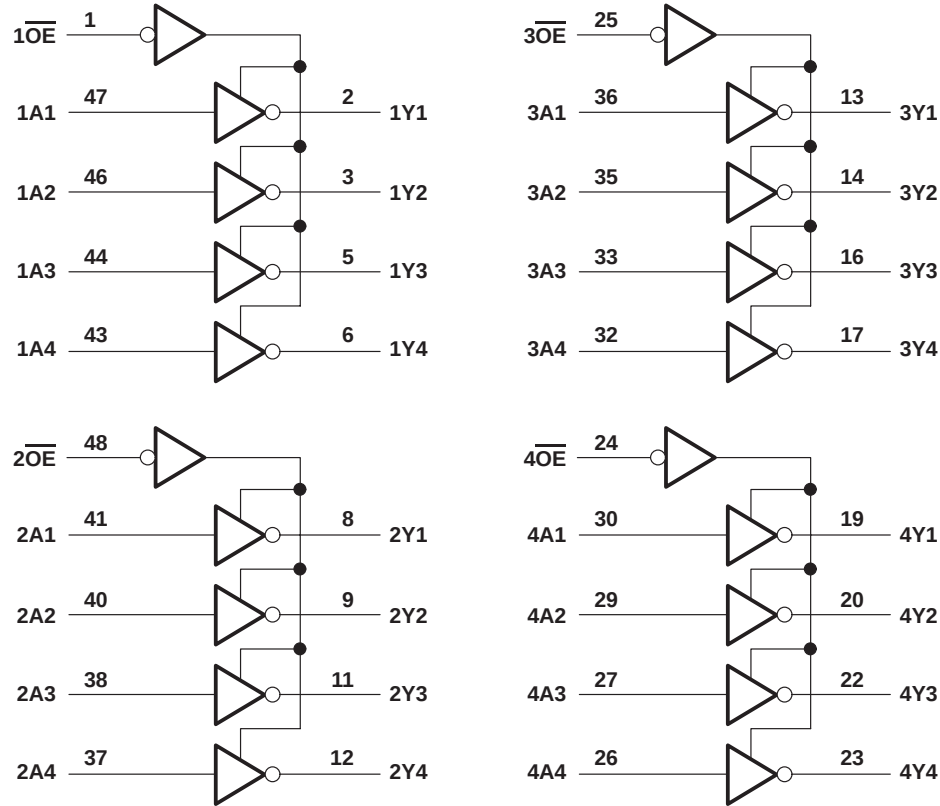
Pin diagram of the 74VHC163 4-bit binary counter. The diagram shows a 16-pin package with pins 1 through 16. Pins 1, 48, 25, and 24 are labeled 1OE, 2OE, 3OE, and 4OE respectively. Pins 47 and 46 are labeled 1A1 and 1A2. Pins 44 and 43 are labeled 1A3 and 1A4. Pins 41 and 40 are labeled 2A1 and 2A2. Pins 38 and 37 are labeled 2A3 and 2A4. Pins 36 and 35 are labeled 3A1 and 3A2. Pins 33 and 32 are labeled 3A3 and 3A4. Pins 30 and 29 are labeled 4A1 and 4A2. Pins 27 and 26 are labeled 4A3 and 4A4. The diagram also shows the internal logic structure of the counter, including the 4-bit binary counter and the 4-bit output register.

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 4.6 V
Input voltage range, V_I (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high-impedance or power-off state, V_O (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high state, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Current into any output in the low state, I_{OL} : SN54LVTH16240	96 mA
SN74LVTH16240	128 mA
Current into any output in the high state, I_{OH} (see Note 2): SN54LVTH16240	48 mA
SN74LVTH16240	64 mA
Input clamp current, I_{IK} ($V_I < 0$)	–50 mA
Output clamp current, I_{OK} ($V_O < 0$)	–50 mA
Package thermal impedance, θ_{JA} (see Note 3): DGG package	89°C/W
DL package	94°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. This current flows only when the output is in the high state and $V_O > V_{CC}$.
3. The package thermal impedance is calculated in accordance with JESD 51.

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recommended operating conditions (see Note 4)

			SN54LVTH16240		SN74LVTH16240		UNIT
			MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage		2.7	3.6	2.7	3.6	V
V_{IH}	High-level input voltage		2		2		V
V_{IL}	Low-level input voltage			0.8		0.8	V
V_I	Input voltage			5.5		5.5	V
I_{OH}	High-level output current			–24		–32	mA
I_{OL}	Low-level output current			48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
$\Delta t/\Delta V_{CC}$	Power-up ramp rate		200		200		μ s/V
T_A	Operating free-air temperature		–55	125	–40	85	°C

NOTE 4: All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54LVTH16240		SN74LVTH16240		UNIT	
				MIN	TYP†	MAX	MIN		TYP†
V _{IK}		V _{CC} = 2.7 V, I _I = −18 mA		−1.2		−1.2		V	
V _{OH}		V _{CC} = 2.7 V to 3.6 V, I _{OH} = −100 μA		V _{CC} −0.2		V _{CC} −0.2		V	
		V _{CC} = 2.7 V, I _{OH} = −8 mA		2.4		2.4			
		V _{CC} = 3 V		I _{OH} = −24 mA		2			
				I _{OH} = −32 mA					2
V _{OL}		V _{CC} = 2.7 V		I _{OL} = 100 μA		0.2		V	
				I _{OL} = 24 mA		0.5			
		V _{CC} = 3 V		I _{OL} = 16 mA		0.4			
				I _{OL} = 32 mA		0.5			
				I _{OL} = 48 mA		0.55			
				I _{OL} = 64 mA		0.55			
I _I		V _{CC} = 0 or 3.6 V, V _I = 5.5 V		10		10		μA	
	Control inputs	V _{CC} = 3.6 V, V _I = V _{CC} or GND		±1		±1			
	Data inputs	V _{CC} = 3.6 V, V _I = V _{CC}		1		1			
		V _{CC} = 3.6 V, V _I = 0		−5		−5			
I _{off}		V _{CC} = 0, V _I or V _O = 0 to 4.5 V				±100		μA	
I _I (hold)	Data inputs	V _{CC} = 3 V		V _I = 0.8 V		75		μA	
				V _I = 2 V		−75			
		V _{CC} = 3.6 V‡, V _I = 0 to 3.6 V				500 −750			
I _{OZH}		V _{CC} = 3.6 V, V _O = 3 V		5		5		μA	
I _{OZL}		V _{CC} = 3.6 V, V _O = 0.5 V		−5		−5		μA	
I _{OZPU}		V _{CC} = 0 to 1.5 V, V _O = 0.5 V to 3 V, OE = don't care		±100*		±100		μA	
I _{OZPD}		V _{CC} = 1.5 V to 0, V _O = 0.5 V to 3 V, OE = don't care		±100*		±100		μA	
I _{CC}		V _{CC} = 3.6 V, I _O = 0, V _I = V _{CC} or GND		Outputs high		0.19		mA	
				Outputs low		5			
				Outputs disabled		0.19			
ΔI _{CC} §		V _{CC} = 3 V to 3.6 V, One input at V _{CC} − 0.6 V, Other inputs at V _{CC} or GND		0.2		0.2		mA	
C _i		V _I = 3 V or 0		4		4		pF	
C _O		V _O = 3 V or 0		9		9		pF	

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

† All typical values are at $V_{CC} = 3.3\text{ V}$, $T_A = 25^\circ\text{C}$.

‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.

§ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

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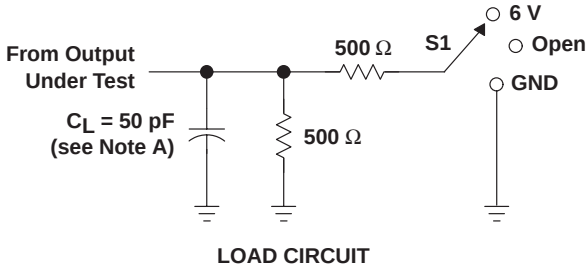
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switching characteristics over recommended operating free-air temperature range, $C_L = 50$ pF
(unless otherwise noted) (see Figure 1)

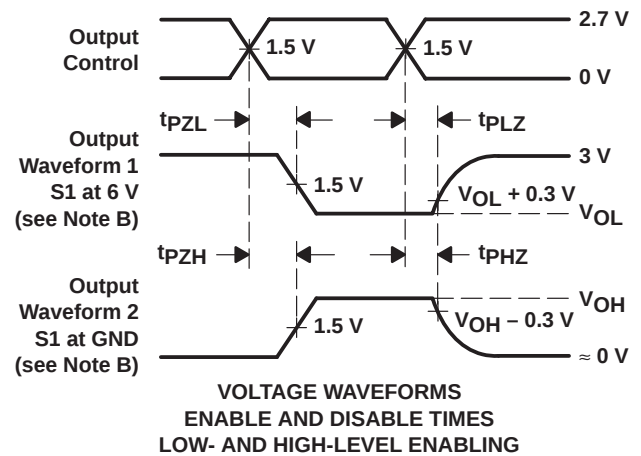
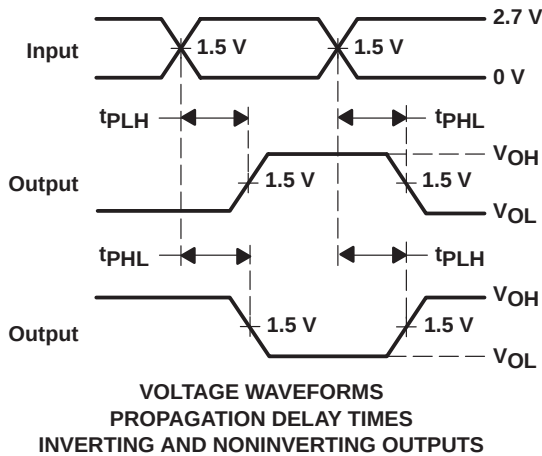
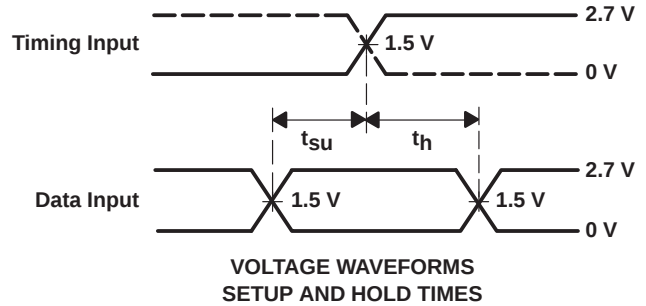
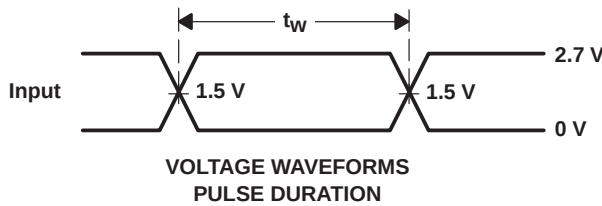
PARAMETER	FROM (INPUT)	TO (OUTPUT)	SN54LVTH16240				SN74LVTH16240				UNIT	
			V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V			V _{CC} = 2.7 V		
			MIN	MAX	MIN	MAX	MIN	TYP†	MAX	MIN		MAX
t _{PLH}	A	Y	1	3.6		4.1	1	2.2	3.5		4	ns
t _{PHL}			1	3.6		4.1	1	2.7	3.5		4	
t _{PZH}	OE	Y	1	4.2		5.1	1	2.6	4		4.9	ns
t _{PZL}			1.1	4.6		4.8	1.2	2.6	4.4		4.6	
t _{PHZ}	OE	Y	1.9	4.7		5.2	2	3.4	4.5		5	ns
t _{PLZ}			1.9	4.4		4.5	2	3.2	4.2		4.2	
t _{sk(o)}									0.5		0.5	ns

[†] All typical values are at $V_{CC} = 3.3\text{ V}$, $T_A = 25^\circ\text{C}$.

PARAMETER MEASUREMENT INFORMATION



TEST	S1
t_{PHL}/t_{PLH}	Open
t_{PLZ}/t_{PZL}	6 V
t_{PHZ}/t_{PZH}	GND



- NOTES:
- A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: $PRR \leq 10 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r \leq 2.5 \text{ ns}$, $t_f \leq 2.5 \text{ ns}$.
 - D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

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